

Search Notes**Application/Control No.**

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Examiner

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Applicant(s)/Patent under Reexamination

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Art Unit

2182

SEARCHED

Class	Subclass	Date	Examiner
710	1,36-45	2/28/2006	CBS
710	72-74	2/28/2006	CBS
711	100-114	2/28/2006	CBS
711	161-164	2/28/2006	CBS
711	170-174	2/28/2006	CBS
707	1	2/28/2006	CBS
707	200-206	2/28/2006	CBS

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
PLUS	2/28/2006	CBS
PALM for Double Patenting	2/28/2006	CBS
EAST (US PGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM TDB)	2/28/2006	CBS

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
710	36,72	3/3/2006	CBS
707	1,205	3/3/2006	CBS
711	112,161	3/3/2006	CBS
711/170		3/3/2006	CBS